

# Optics Development for LIGO

---

Stan Whitcomb

14 November 1996

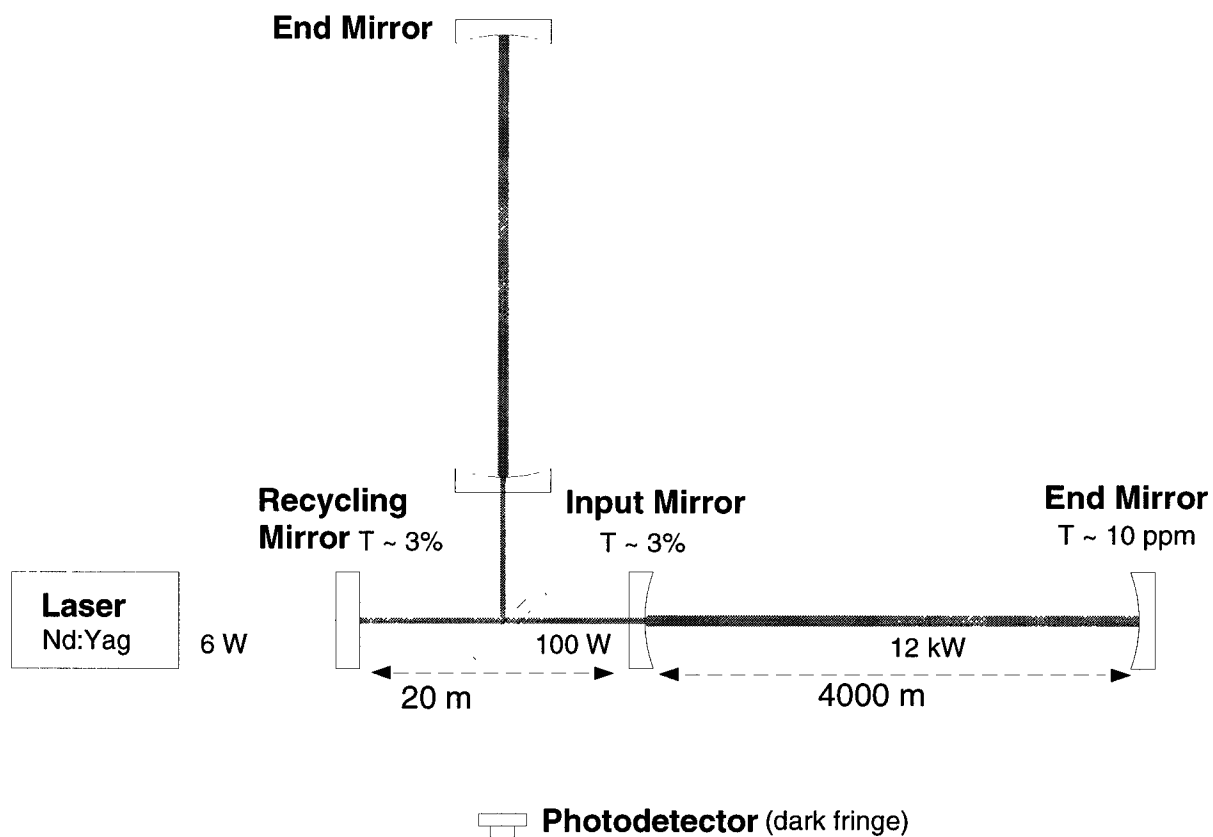


CALIFORNIA INSTITUTE OF TECHNOLOGY  
MASSACHUSETTS INSTITUTE OF TECHNOLOGY

LIGO-G960224-00-D

# Large Optical Components ("Core Optics")

- Test Masses
  - ›› End Mirror
  - ›› Input Mirror
- Beamsplitter
- Recycling Mirror
- Total Number: 20
  - ›› WA 4km: 6 Optics
  - ›› WA 2km: 8 Optics
  - ›› LA 4km: 6 Optics
- + Spares



# Core Optics

---

- High purity fused silica

- ›› 25 cm diameter x 10 cm thick (except beamsplitter: 4cm thick)

- ›› Beams fill some optics (to ~1ppm level)

- ›› 1064 nm HR mirrors and AR second surface coatings.

- Principal performance requirements:

- ›› < 50 ppm loss per surface (limits resonant stored energy: shot noise)

- ›› Surface figure errors to scatter negligible power from TEM<sub>00</sub> (best dark fringe)

- Similar requirement for bulk inhomogeneity

- ›› High mechanical Q to “suppress” thermal noise ( $Q \geq \text{few} \times 10^6$ )

- ›› Low bulk (<~5ppm/cm) and coating (<2ppm) absorption (thermal lensing limit to beam power and dark fringe contrast).



# Optics Development Program ("Pathfinder")

---

- Purchase and evaluate fused silica blanks (5/94)
  - ›› Corning 7940 OAA Grade
- Best effort polishing of substrates (8/95-4/96)
  - ›› Commonwealth Scientific and Industrial Research Organization (CSIRO)
  - ›› General Optics (GO)
  - ›› Hughes-Danbury Optical Systems (HDOS)
- Independent substrate metrology (4/96-8/96)
  - ›› National Institute of Standards and Technology (NIST)
- Coating uniformity development (7/95-ongoing)
  - ›› Research Electro Optics (REO)
- Coated optic metrology (NIST, early '97)
- Analysis of all data in LIGO computer model



# Defining the Optics Requirements

---

- Primary tool is computer model of full recycled interferometer
  - ›› FFT-based optical propagation code
  - ›› Includes the surface figure of all optical components (either real or simulated)
  - ›› Includes OPD of substrates
  - ›› Solves for carrier and sidebands for modulation/demodulation
- Contributions from many people
  - ›› Original code courtesy of Jean-Yves Vinet and Patrice Hello (VIRGO)
  - ›› Extensive modification and enhancement by Partha Saha, Yaron Hefetz, and Brett Bochner
  - ›› Used to establish LIGO requirements by Bill Kells



# Core Optics Requirements

- Tight matching of all optical parameters arm to arm

<i>Physical Quantity</i>	<i>Test Mass</i>		<i>Beam splitter</i>	<i>Recycling mirror</i>
	<i>End</i>	<i>Input</i>		
<b>Diameter of substrate, <math>\phi_s</math> (cm)</b>	<b>25</b>	<b>25</b>	<b>25</b>	<b>25</b>
<b>Substrate Thickness, <math>d_s</math> (cm)</b>	<b>10</b>	<b>10</b>	<b>4</b>	<b>10</b>
<b>1 ppm intensity contour diameter (cm)</b>	<b>24</b>	<b>19.1</b>	<b>30.2<sup>a</sup></b>	<b>19.2</b>
<b>Lowest internal mode frequency (kHz)</b>	<b>6.79</b>	<b>6.79</b>	<b>3.58</b>	<b>6.79</b>
<b>Mass of Suspended Component (kg)</b>	<b>10.7</b>	<b>10.7</b>	<b>6.2</b>	<b>10.7</b>
<b>Nominal surface 1 radius of curvature (m) and <math>g_i</math> factor</b>	<b>7400 <math>g_2=.46</math></b>	<b>14540 <math>g_1=.725</math></b>	$\infty$	<b>9890 <math>g=.9984</math></b>
<b>Tolerance on radius of curvature (m)</b>	<b>absolute: +220 matching: <math>\pm 111</math></b>	<b>-1000, +145</b>	<b>&gt;-720 km convex, &gt;200 km concave</b>	<b>-100, +500</b>

a. For these 45° angle of incidence optics, this is the smallest diameter circle centered on the optic face which is everywhere outside of the 1 ppm intensity field.



# Substrate Material Results

---

- Optical homogeneity measured and evaluated using FFT model
  - ››OPD maps of best grade fused silica indicate sufficient homogeneity
  - ››Bulk  $\Delta n \leq 5 \cdot 10^{-7}$  through 10cm.
- Mechanical Q's measured  $> 8 \cdot 10^6$  (lowest 5)
- High  $dn/dT$  coefficient for silica requires very low absorption.
  - ››VIRGO measurements correlate 1064 nm absorption with OH concentration.
  - ››Typical process: 500-1000 ppm OH (10-20 ppm/cm absorption): Heraeus process ~200 ppm OH (~5 ppm/cm absorption).
  - ››Only critical for input mirror and splitter.
- Orders for ~40 blanks have been placed
  - ››Heraeus selected for input mirrors and splitters and Corning for all others
  - ››Spares and allowance for in-process problems



# Core Optics-Polishing Demonstration

---

- Best Effort Polishing/Metrology of Substrates
  - ›› HDOS, CSIRO, GO
  - ›› Flat on one side;  $R = 6000$  m on other side
  - ›› Goal: “mid scale” surface figure errors  $< .8$  nm rms (central 8 cm diameter)
  - ›› Goal:  $< 0.4$  nm rms microroughness
- Independent Substrate Metrology
  - ›› NIST (C. Evans, R. Parks, et al.)
  - ›› PMI absolute metrology, multiply redundant measurement approach
  - ›› Surface scales  $\geq 3$ mm using existing 633 nm equipment
- LIGO supervision, coordination, analysis
  - ›› GariLynn Billingsley, Doug Jungwirth, Bill Kells, Cathy Kreath (consultant), Rick Savage, Rai Weiss





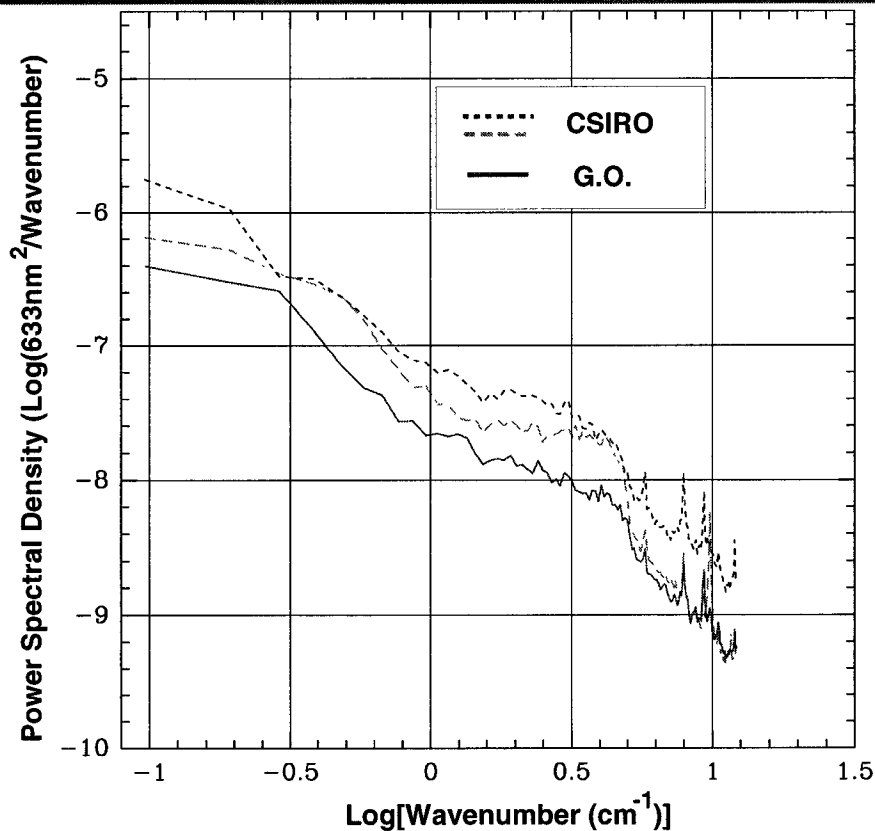
# Core Optics-Polishing

---

- Conclusion: rms deviation from sphere  $< 1$  nm over 20cm diameter are achievable!
  - ›› In some cases, apparent rms  $\sim 0.5$  nm measured
- With care, measurements at  $\leq 1$  nm level possible
  - ›› Reproducible features seen; Consistent intercomparisons demonstrated
  - ›› Small, subtle systematic effects noticed
    - Flat reference vs. curved surface
    - Fizeau path differences
    - Focus effects
- GO and CSIRO selected to polish LIGO Core Optics



# Pathfinder Polishing: Surface Figure



One dimensional power spectra from NIST metrology of curved surfaces. Z(0,0),Z(1,1) Z(2,0),Z(2,2),Z(3,1),Z(3,3),Z(4,0) removed

››NIST Measurements

››HDOS-polished optics comparable



# Pathfinder Polishing: Microroughness

---

- Comparative surface roughness measurements made at REO

Polisher	Optic/Surface	Microroughness ( $\text{\AA}$ rms)	
		Micromap SW (5 location ave.)	PSD area analysis (R. Weiss)
CSIRO	006/Curved	3.6	3.7
	006/Flat	2.8	2.7
	002/Curved	2.7	3
	002/Flat	3.1	3
GO	005/Curved	0.85	0.6 - 1.4
	005/Flat	0.88	0.7 - 1.2

››HDOS results comparable to CSIRO

››CSIRO (and HDOS) improving microroughness



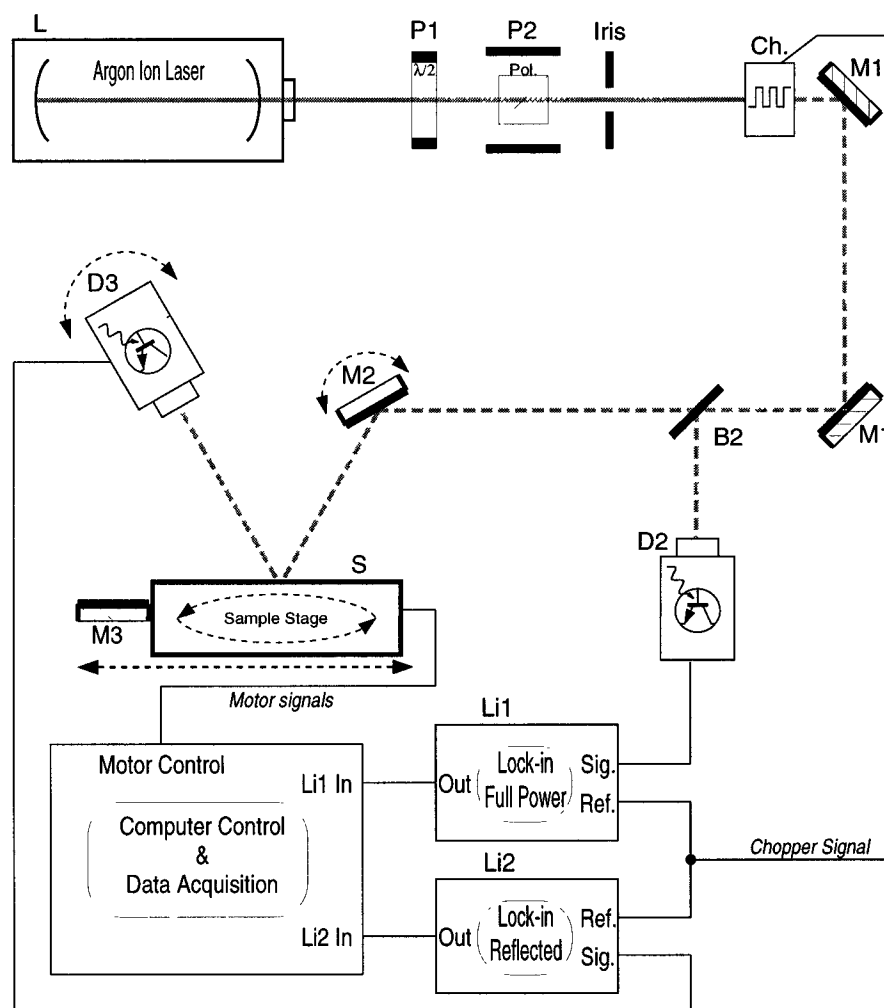
# Coating Uniformity Development

---

- Coating Uniformity Development: REO
  - ›› Goal: Scale up low loss ion beam sputtered coating technology to LIGO diameters
  - ›› Preliminary test pieces show good uniformity to 15 cm diameter
  - ›› Final verification: Coat Pathfinder optics for 633 nm and test
- Development of new test technique
  - ›› Measurements: Doug Jungwirth, Alex Golovitser
  - ›› Analysis: Hiro Yamamoto, Bill Kells
  - ›› Coatings: Research Electro Optics, Ramin Lalezari



# Coating Uniformity Measurements



- Map reflectivity of specially designed AR coating

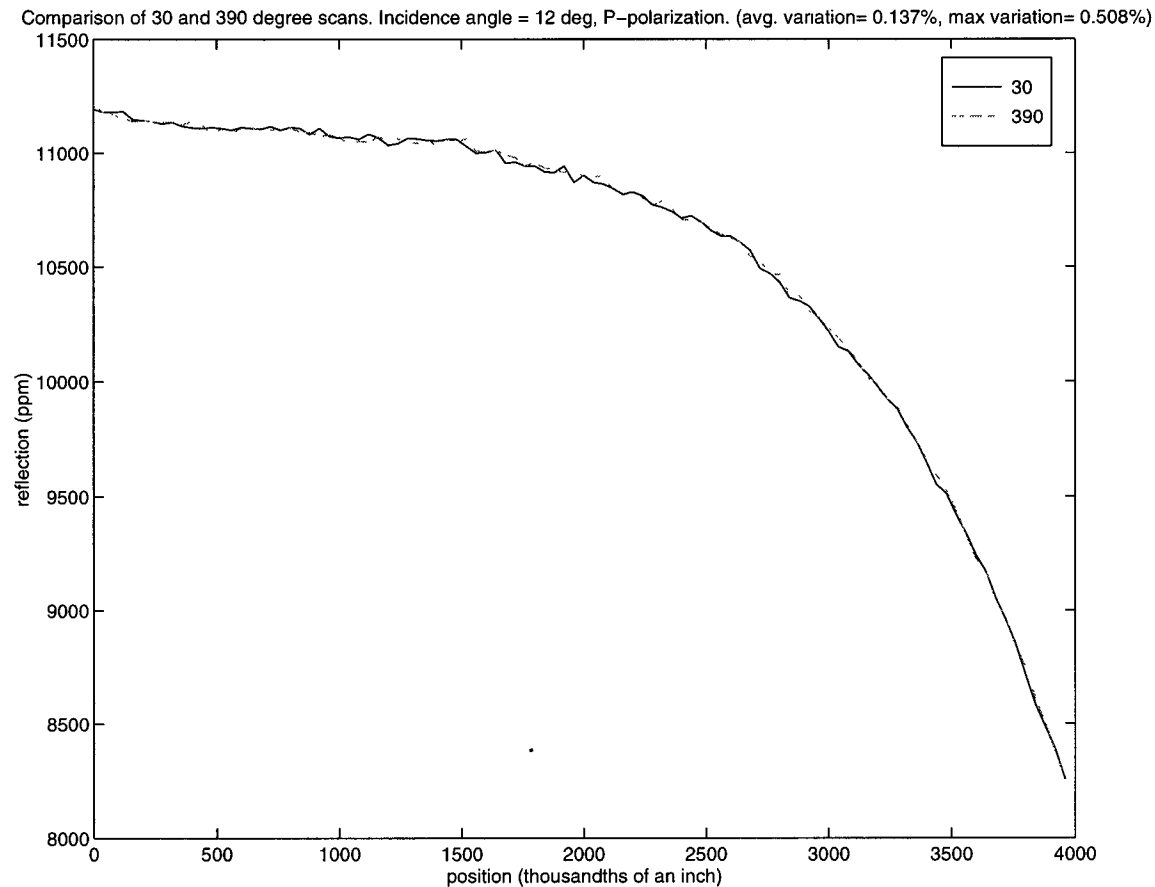
- ›› Insensitive to surface figure of underlying substrate
- ›› Can investigate uniformity of individual coating layers

- Make measurements at:

- ›› 2 Polarizations
- ›› 3 Angles

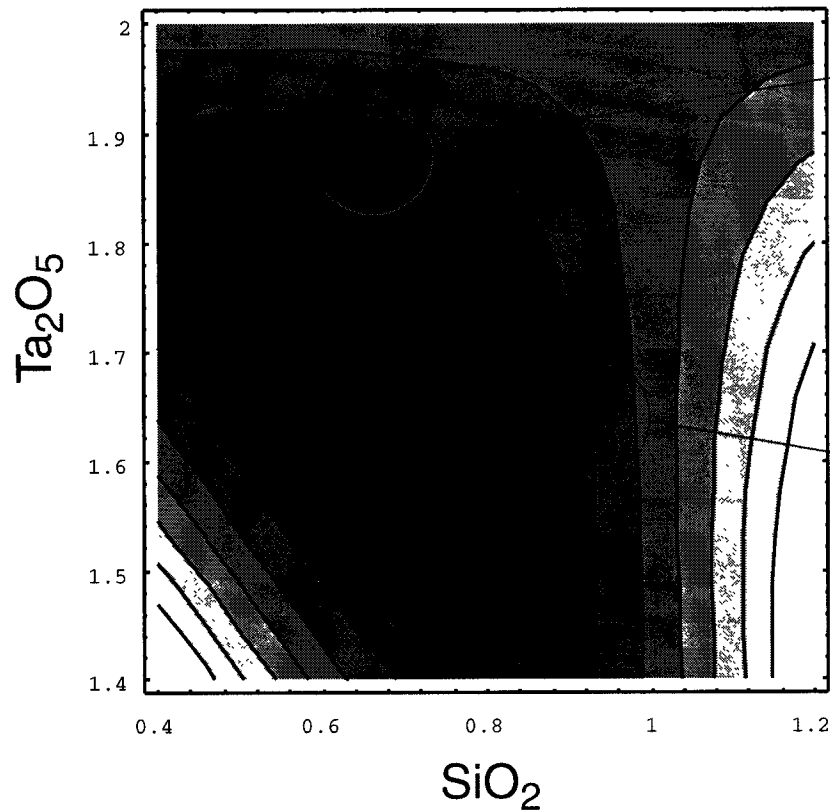
# Coating Reflectivity Data

- Typical radial scan shows good reproducibility ( $\sim 0.2\%$ )

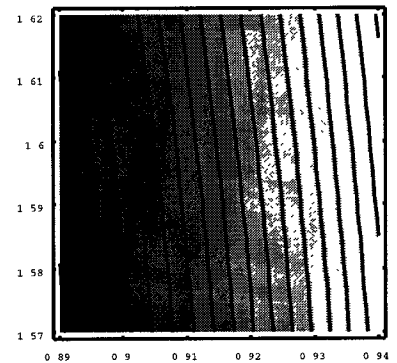
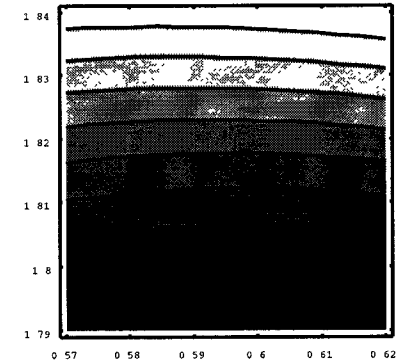


# Test AR Coating Design

- Optimize design for maximum sensitivity to particular layer

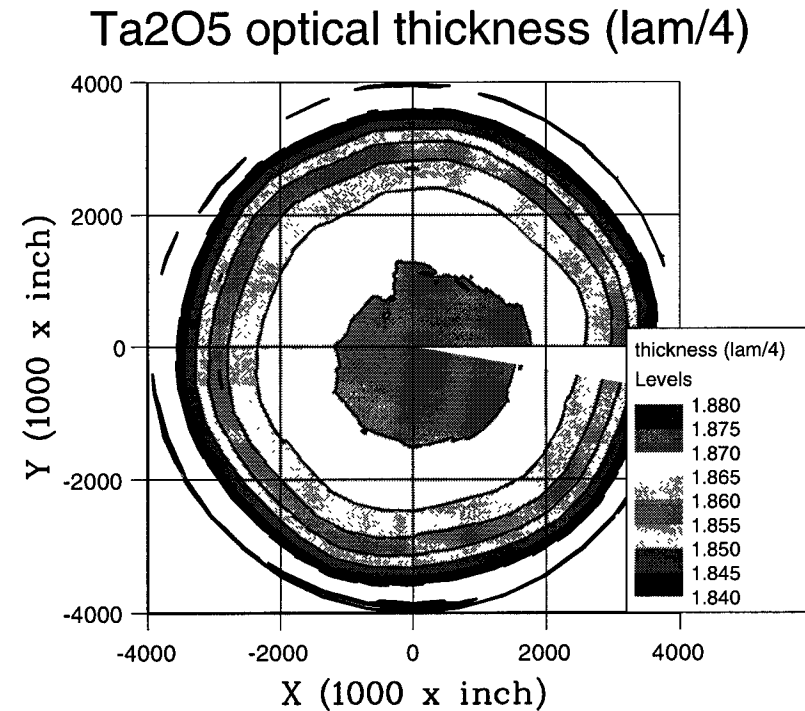
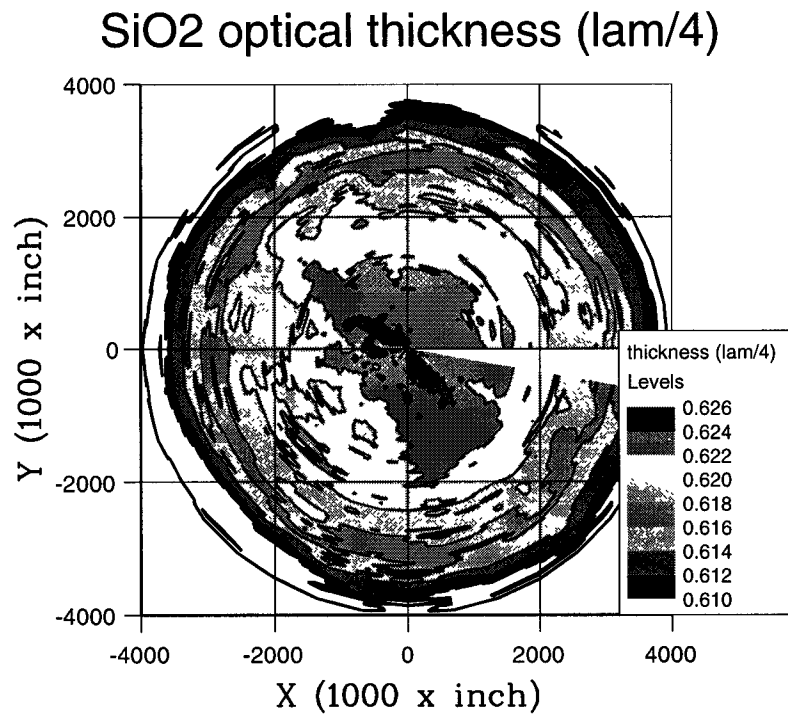


First Design  
Tested



# Individual Layer Maps

- Individual layer thicknesses determined by least squares minimization process

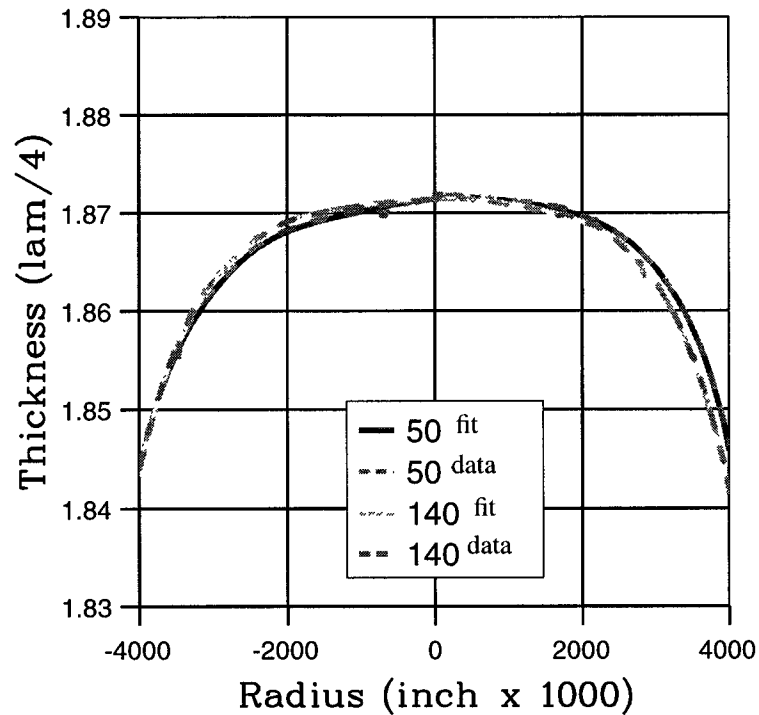




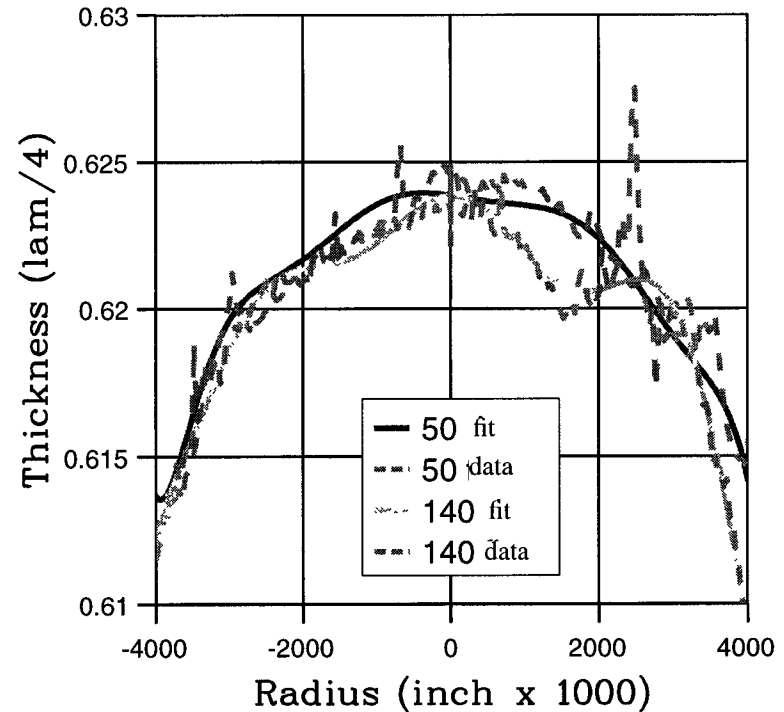
# Sample Scans and Fits

- Fit Data to Zernike polynomials up to tenth order
- Deviations from fits consistent with measurement errors

Ta<sub>2</sub>O<sub>5</sub> Thickness at 50 and 140 degree



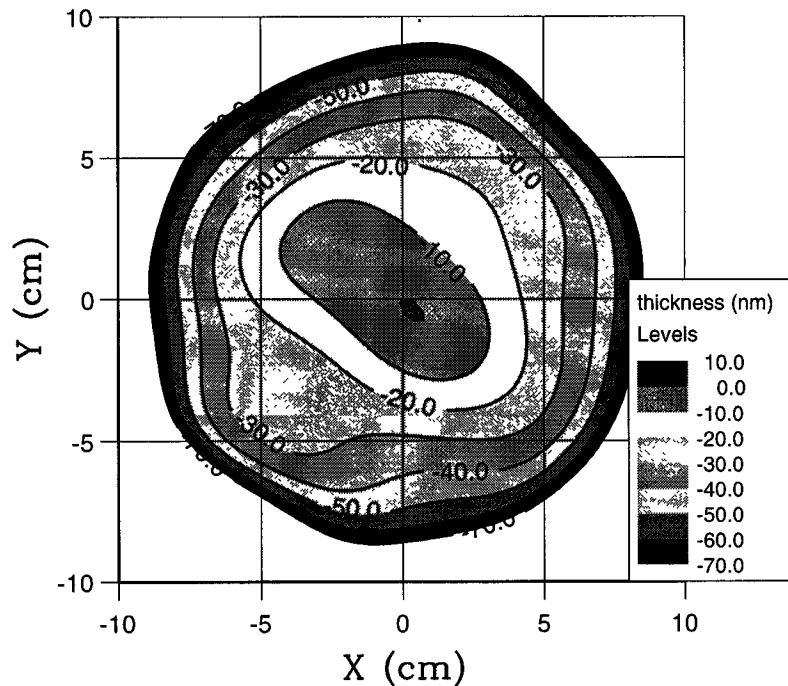
SiO<sub>2</sub> Thickness at 50 and 140 degree



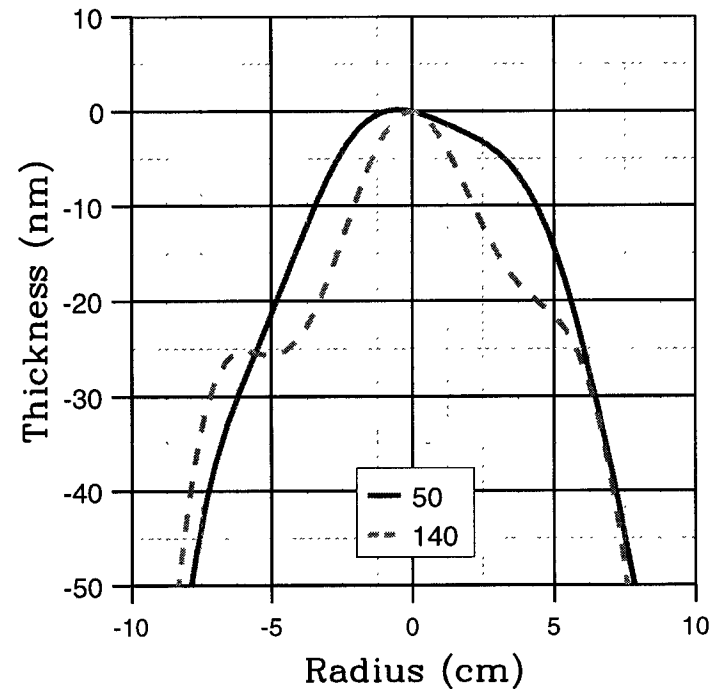
# Extrapolate to Full HR Coatings

- Use fits to individual layers to synthesize predicted phase map for HR coatings

40 layer HR coating phase map



40 layer HR coating phase map



# Preliminary Coating Assessment

---

- Have used FFT-model to assess performance in LIGO interferometer

<i>Run Conditions</i>	<i>Surface Figure (<math>\text{\AA}</math> rms)</i>	<i>Recycling Factor</i>	<i><math>h(100 \text{ Hz})</math> (<math>\times 10^{-23} \text{ Hz}^{-1/2}</math>)</i>
<b>Standard Configuration: Measured Substrate OPD's Surface Phase Maps Based on Polished Substrates</b>	<b>0.8</b>	<b>52</b>	<b>1.39</b>
<b>Standard Configuration, except 40 Layer HR substituted on End Test Mass</b>	<b>3.8 (ETM)</b>	<b>17</b>	<b>2.14</b>
<b>Standard Configuration, except 16 Layer HR substituted on Input Test Mass</b>	<b>1.9 (ITM)</b>	<b>33</b>	<b>1.73</b>
<b>Standard Configuration, except 40 Layer HR substituted on End Test Mass and 16 Layer HR substituted on Input Test Mass</b>	<b>3.8 (ETM) 1.9 (ITM)</b>	<b>15</b>	<b>2.52</b>

- Some loss in sensitivity but within a factor of 2 of required uniformity



# Coating Uniformity: Next Steps

---

- Make coating adjustments to reduce curvature (REO)
- Two new test AR coating runs
  - ›› Separately test  $\text{SiO}_2$  and  $\text{Ta}_2\text{O}_5$
- Coat Pathfinder optics with HR coatings
- Measure reflected phase at NIST to confirm scaling from single layers to HR coatings



# Summary

---

- Tools and techniques (both experimental and analytical) in place to evaluate LIGO optics against requirements
- Substrate material and polishing appear to be adequate for initial LIGO interferometers
- Preliminary coating uniformity data promising; further improvements and testing expected within the next few months

